List of Patents and Publications for Applicant's

NFORMATION DISCLOSURE STATEMENT

Atty. Docket No. 2000.109000/DE0133 Serial No. 10/666,195

Applicant

Gerd Marxsen, Axel Preusse, Markus Nopper and Frank Mauersberger

Filing Date:

Group: .

(Use several sheets if necessary)

September 19, 2003
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Other Art

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